

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10051726	UY ET AL.
	Examiner	Art Unit
	HAL I KAPLAN	2836

SEARCHED

Class	Subclass	Date	Examiner
307	65	2/5/2009	HK
307	85	2/5/2009	HK
307	86	2/5/2009	HK
307	87	2/4/2009	HK
307	130	2/4/2009	HK
327	518	2/4/2009	HK
327	520	2/4/2009	HK

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US- PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/4/2009	HK
EAST (US- PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/5/2009	HK
307/64-66 (cursor)	2/5/2009	HK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner